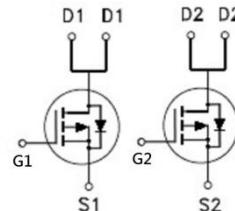


NIKO-SEM
**Dual P-Channel Enhancement Mode
Field Effect Transistor**
PV561DA
SOP-8
Halogen-free & Lead-Free
PRODUCT SUMMARY

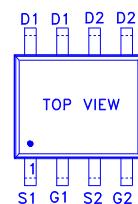
$V_{(BR)DSS}$	$R_{DS(ON)}$	I_D
-30V	45mΩ	-5.2A

**Features**

- Pb-Free, Halogen Free and RoHS compliant.
- Low $R_{DS(on)}$ to Minimize Conduction Losses.
- Ohmic Region Good $R_{DS(on)}$ Ratio.
- Optimized Gate Charge to Minimize Switching Losses.

Applications

- Protection Circuits Applications.
- Logic/Load Switch Circuits Applications.


G : GATE
D : DRAIN
S : SOURCE

100% UIS Tested
100% Rg Tested
ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$ Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS	SYMBOL	LIMITS	UNITS
Drain-Source Voltage	V_{DS}	-30	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current	I_D	-5.2	A
		-4.1	
Pulsed Drain Current ¹	I_{DM}	-20	
Avalanche Current	I_{AS}	-14	
Avalanche Energy	E_{AS}	9.8	mJ
Power Dissipation ³	P_D	2	W
		1.3	
Junction & Storage Temperature Range	T_j, T_{stg}	-55 to 150	°C

THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM	UNITS
Junction-to-Ambient ²	$R_{\theta JA}$	60	92	°C / W
Junction-to-Ambient ²	Steady-State			
Junction-to-Case	$R_{\theta JC}$			

¹Pulse width limited by maximum junction temperature.

²The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A = 25^\circ\text{C}$.

³The Power dissipation is based on $R_{\theta JA}$ t ≤ 10s value.

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ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$, Unless Otherwise Noted)

PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT
			MIN	TYP	MAX	
STATIC						
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$V_{\text{GS}} = 0\text{V}, I_D = -250\mu\text{A}$	-30			V
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}} = V_{\text{GS}}, I_D = -250\mu\text{A}$	-1.3	-1.75	-2.3	
Gate-Body Leakage	I_{GSS}	$V_{\text{DS}} = 0\text{V}, V_{\text{GS}} = \pm 20\text{V}$			± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{\text{DS}} = -24\text{V}, V_{\text{GS}} = 0\text{V}$			-1	μA
		$V_{\text{DS}} = -20\text{V}, V_{\text{GS}} = 0\text{V}, T_J = 55^\circ\text{C}$			-10	
Drain-Source On-State Resistance ¹	$R_{\text{DS}(\text{ON})}$	$V_{\text{GS}} = -4.5\text{V}, I_D = -5\text{A}$		55	75	$\text{m}\Omega$
		$V_{\text{GS}} = -10\text{V}, I_D = -5\text{A}$		33	45	
Forward Transconductance ¹	g_{fs}	$V_{\text{DS}} = -5\text{V}, I_D = -5\text{A}$		13		S

DYNAMIC

Input Capacitance	C_{iss}	$V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = -15\text{V}, f = 1\text{MHz}$	502		pF
Output Capacitance	C_{oss}		83		
Reverse Transfer Capacitance	C_{rss}		63		
Gate Resistance	R_g	$V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = 0\text{V}, f = 1\text{MHz}$	14.7		Ω
Total Gate Charge ²	Q_g	$V_{\text{DS}} = -15\text{V}, V_{\text{GS}} = -10\text{V}, I_D = -5\text{A}$	10.5		nC
Gate-Source Charge ²	Q_{gs}		1.7		
Gate-Drain Charge ²	Q_{gd}		2.6		
Turn-On Delay Time ²	$t_{\text{d}(\text{on})}$	$V_{\text{DD}} = -15\text{V}$ $I_D \approx -5\text{A}, V_{\text{GS}} = -10\text{V}, R_{\text{GEN}} = 6\Omega$	11		nS
Rise Time ²	t_r		33		
Turn-Off Delay Time ²	$t_{\text{d}(\text{off})}$		55		
Fall Time ²	t_f		44		

SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS ($T_J = 25^\circ\text{C}$)

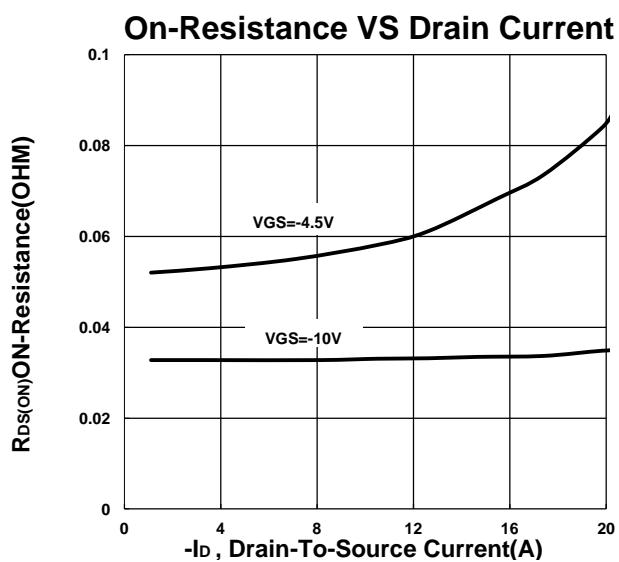
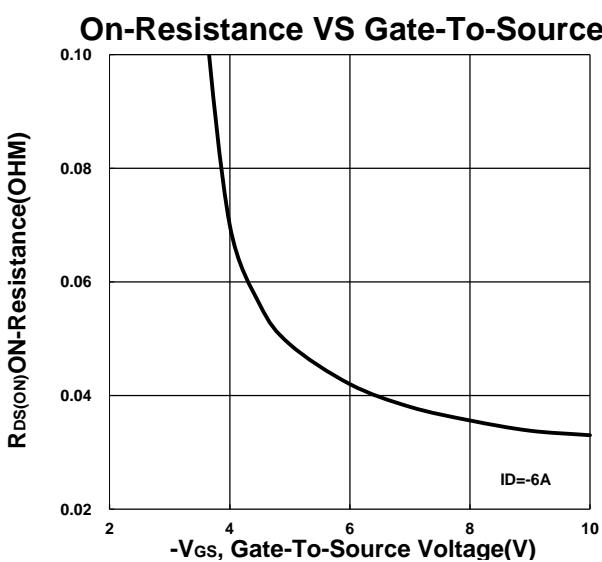
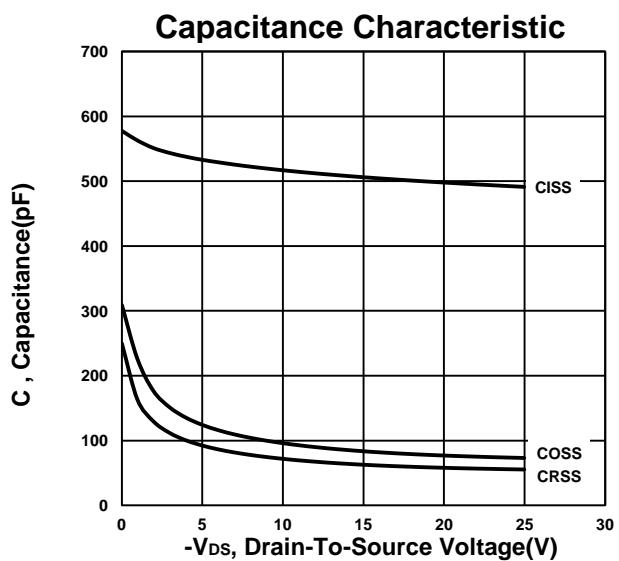
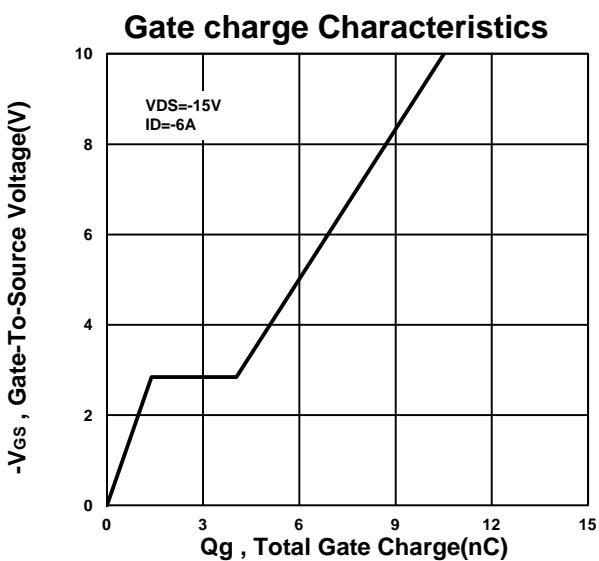
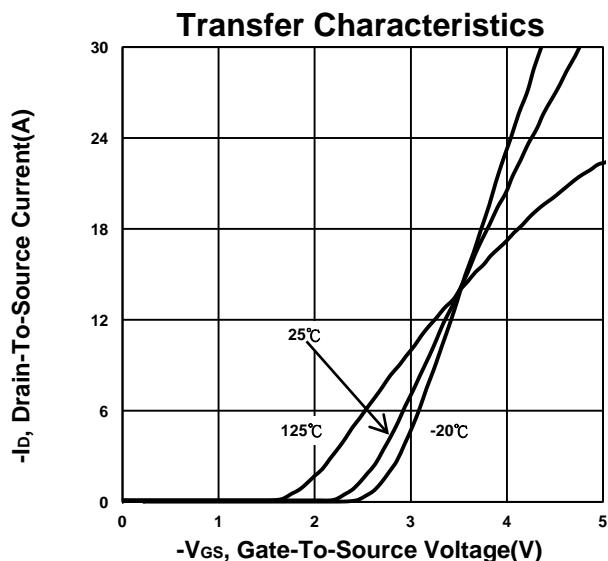
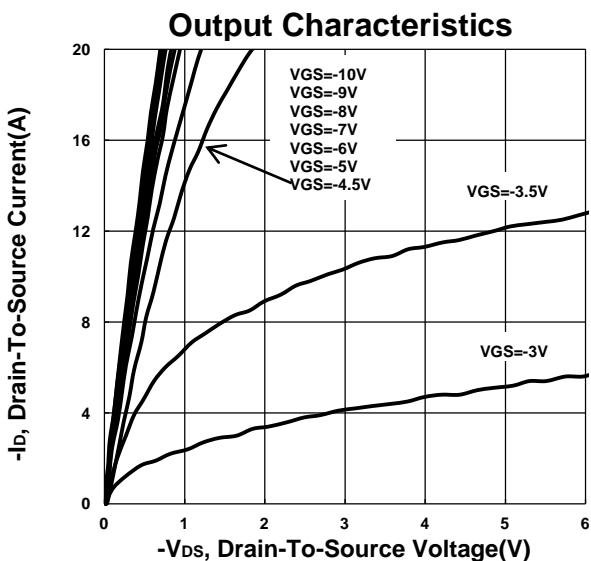
Continuous Current	I_S				-2	A
Forward Voltage ¹	V_{SD}	$I_F = -5\text{A}, V_{\text{GS}} = 0\text{V}$			-1.2	V
Reverse Recovery Time	t_{rr}	$I_F = -5\text{A}, dI/dt = 100\text{A}/\mu\text{s}$	10			nS
Reverse Recovery Charge	Q_{rr}		3			nC

¹Pulse test : Pulse Width $\leq 300\ \mu\text{sec}$, Duty Cycle $\leq 2\%$.²Independent of operating temperature.

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